

Abstract Submitted  
for the 4CF09 Meeting of  
The American Physical Society

**Ge and Ge-rich Group IV Alloys on Si for Photonic Device Applications** JAY MATHEWS, JOSE MENENDEZ, VIJAY D'COSTA, Department of Physics, Arizona State University, Tempe, AZ, 85287-1504, USA, SHUI-QING YU, Department of Electrical Engineering, University of Arkansas, Fayetteville, AR 72701, USA, RADEK ROUCKA, JUNQI XIE, YANYAN FANG, JOHN KOU-VETAKIS, Department of Chemistry and Biochemistry, Arizona State University, Tempe, AZ, 85287-1604, USA — The application of silicon photonic technologies to optical telecommunications requires the development of near-infrared detectors monolithically integrated to the Si platform. Recently, new low-temperature CVD techniques have been developed for growth of high-quality epitaxial films of Ge,  $\text{Ge}_{1-y}\text{Sn}_y$ , and  $\text{Si}_x\text{Ge}_{1-x-y}\text{Sn}_y$  directly on Si. In this poster, we present details on the growth of these films, optimization of processes for the fabrication of photonic devices, and results from some prototype p-i-n heterostructure devices.

Jay Mathews  
Dept of Physics, Arizona State University, Tempe, AZ, 85287-1504, USA

Date submitted: 29 Sep 2009

Electronic form version 1.4